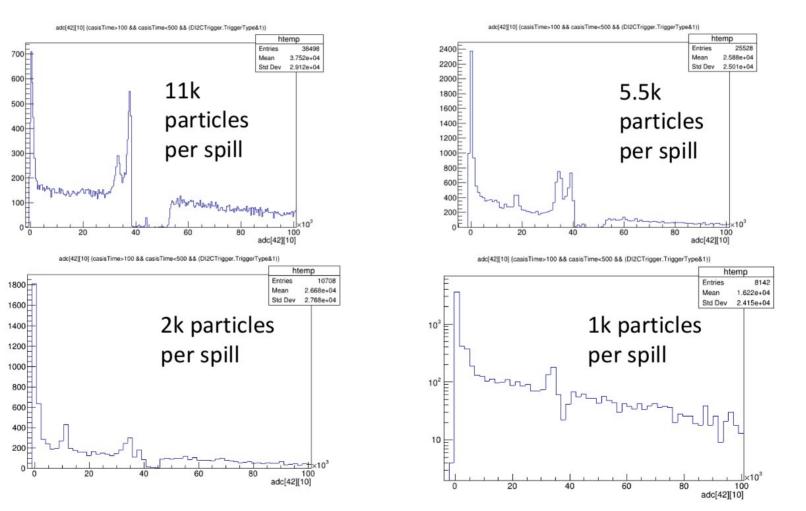
The "peak" on the HG-LG switching region: tests and solution.

Lorenzo Pacini, 07/02/2024

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Main goal: understand SPS2023 data



Testing with 2 LED pulses and 3 triggers

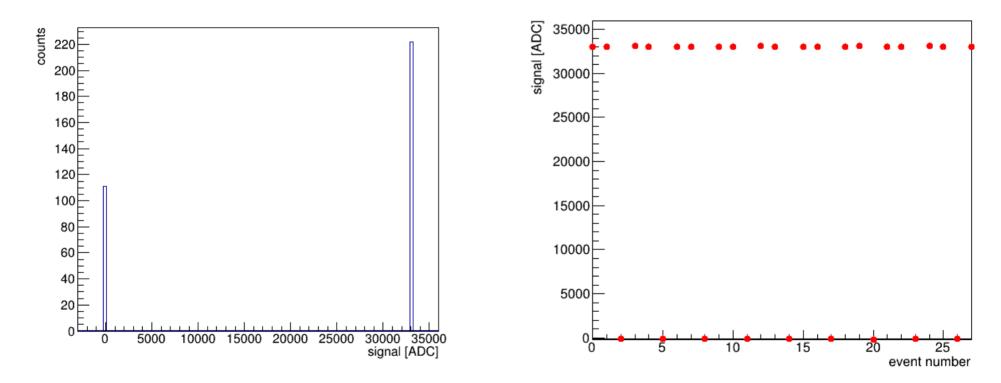
- After several tests with LED we guessed that the problem was due to a charge injection <u>after</u> the trigger and during the HOLD signal
- > We implemented a signal sequence: trigger \rightarrow LED pulse \rightarrow trigger \rightarrow LED pulse \rightarrow trigger
- LED: pulse delay from 0 to 600 us, amplitude 5 V, pulse width 3 us
- > An example (pulse delay 150 us): oscilloscope signals





Hypothesis confirmation

Channel 17, chip 8, LED delay 150 us:



First and second triggers of each bunch are affected by the following LED pulses, the readout signals are consistent with the peak observed in SPS2023 data.

Checking the logic HIDRA signals

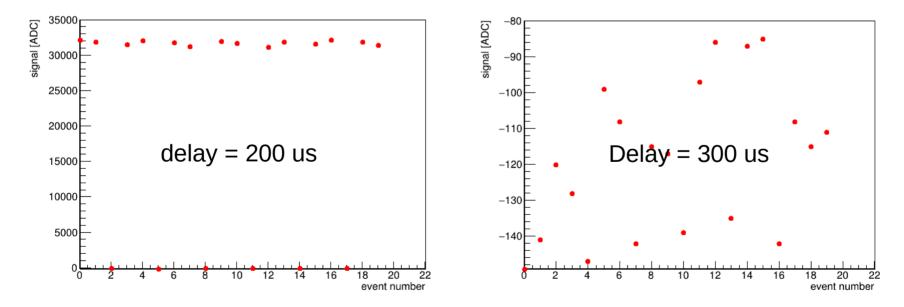
- > We checked directly on the chip pins:
 - HOLD (both LVDS inputs)
 - GHOLD (both LVDS inputs)
 - CDS_R, CSA_RH, CSA_RS (both LVDS inputs)
 - CAL_EN and other CAL signals
- > All the signals are consistent with the expected sequence, here few examples:





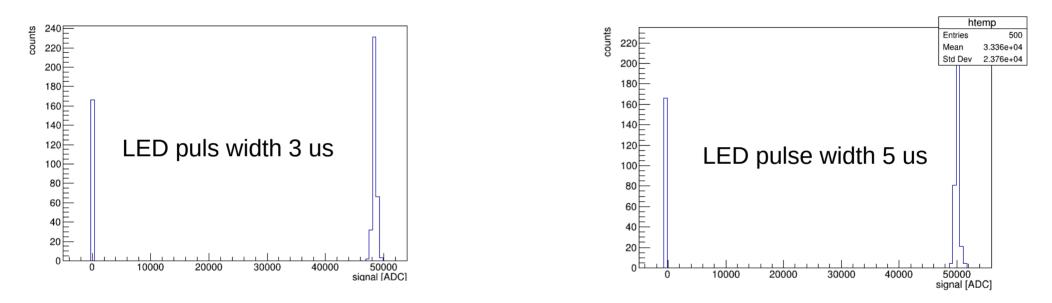
Peak position vs LED delay

- > We changed the LED delay (3 triggers 2 LED pulses configuration):
 - > the peak values is almost the same for each delay up to a specific value (d_M).
 - > If the delay > d_M the peak is not present.
 - > d_M depends on the channel number, particularly in the channel conversion time.



Removing GHOLD

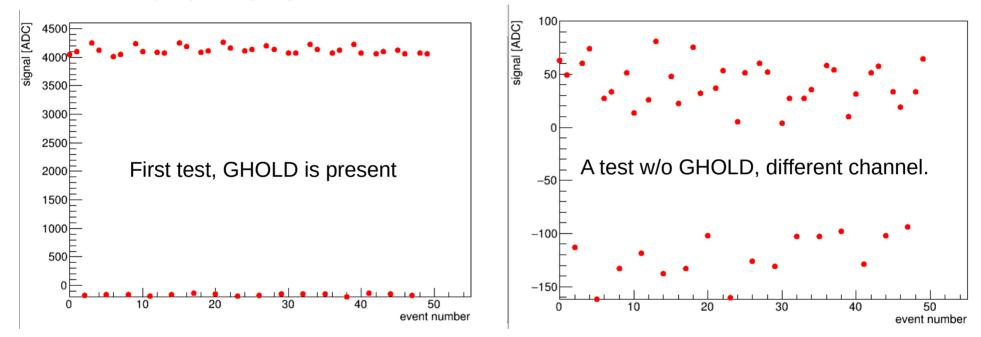
Removing the GHOLD could allow the chip to switch gain after the HOLD.



- > The value of the signals increase (35k \rightarrow 50k), these slightly depend on the injected charge values, d_M remains the same.
- > The channel is in low gain! (by checking the low gain flag on the data).

LED signals in HG region

We tested by injecting signals in HG (i.e. 1 us pulse width)

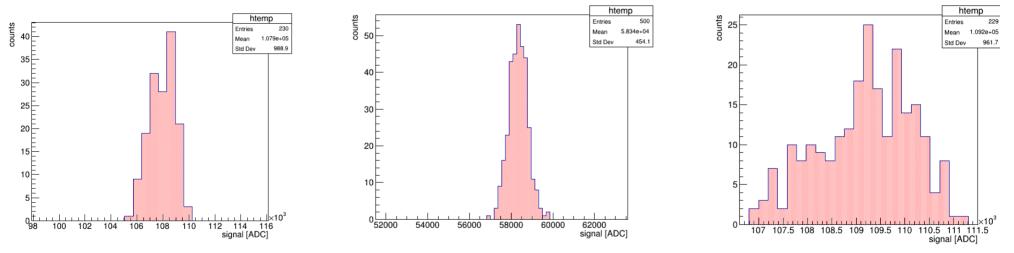


- > A effect is present but the value is not consistent among different tests and channels.
- > It is not clear if GHOLD affects the HG problem.

Test with two LED pulses

A LED pulse is sent with delay = 0, pulse width 3 us.

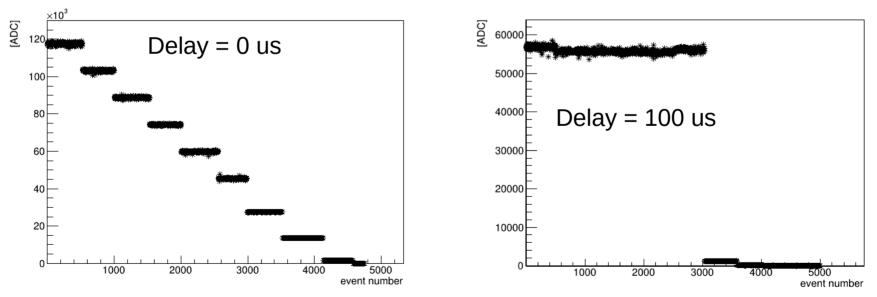
A LED pulse is sent with delay = 150 us, pulse width 3 us. A LED pulse is sent with delay = 0, a second is sent with delay = 150 us, pulse width 3 us.



Sending a delayed LED pulse after a standard LED pulse, the signal is the same of having a single LED pulse with delay = 0.

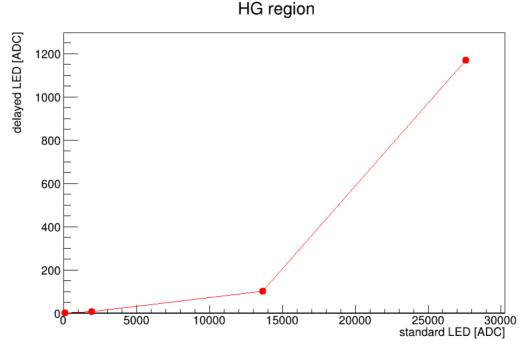
Check the linearity of this effect

- Short LED pulses (~300 ns), at high frequency (2.5 MHz).
- The number of LED pulses is decreased for each ~500 events to scan a large range of signals
- The acquisition is done with delay = 0 (used for calibration) and delay = 100 us (the actual measurement).



Check the linearity of this effect (2)

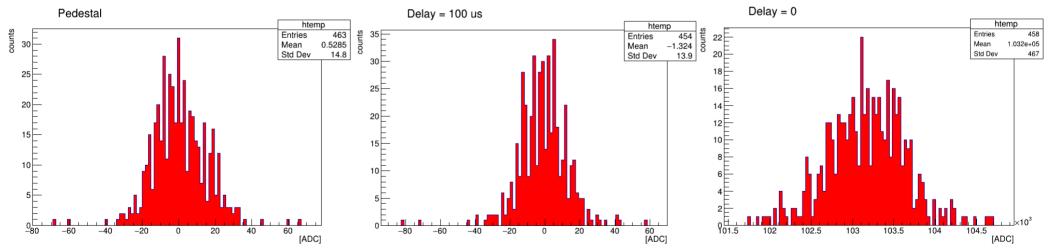
- > In LG region: the signal due to delayed LED is clearly not proportional with the injected light.
- In HG region we check the correlation between delayed and standard LED pulse measurements



Even in HG the delayed signal is not directly proportional with the injected charge.

Preliminary solution of the problem

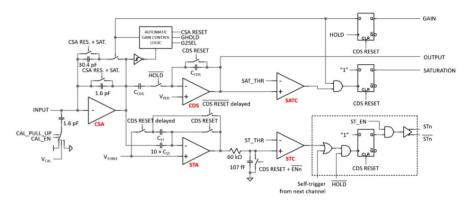
- > Solution suggested by Gianluigi and Nicola: to send the CSA rests during the HOLD
- Monica adjusted the firmware to send CSA_RST (H and S) after the HOLD rising edge (100 ns). The resets are high until the HOLD falling edge.
- Preliminary tests: the peak disappears, the noise is reasonable, the LED signal with delay = 0 is consistent with the expected one



Great results!

Summary of tests.

- The "peak" is due to charge injection (in LG range) during the HOLD.
- The rate and the delay of the charge injection does not strongly affect this feature.
- The feature is present if the charge injection delay is minor of the channel conversion time.
- By removing the GHOLD signal: the value of the signal increases and the channel is in low gain.
- Even if the injected signal is in HG range, some effect are present: the peak position is not proportional with the injected charge.
- The problem seems solved by sending the CSA_RST (H+S) during the HOLD.
- > 2024 beam tests: we will use adjusted firmware.



Two questions: 2) which is the cause of the problem? 1) without GHOLD, it seems that the gain change when the HOLD is high, how is it possible?

Backup

Laboratory test set-up

- > A blue LED injects light inside a LYSO cube coupled with PDs. LED parameters:
 - > amplitude \rightarrow 5 V
 - > Pulse width \rightarrow from 1 us to 6 us.
 - HG-LG threshold corresponds to 1.2 us pulse.
- > The main goal of the test is to check the following hypothesis related to the peak around 35k:
 - > The effect depends on the rate.
 - > It is related to the base line shift.
 - > It is related to the charge obtained from the previous events.
- Very long story short (see next slides for details):
 - * this problem is present even with a single charge injection thus it is not related to previous charge injections and baseline shifts,
 - the peak is due to a charge injection after the trigger, even with a time distance of > 50 us.

d_M value for different channels

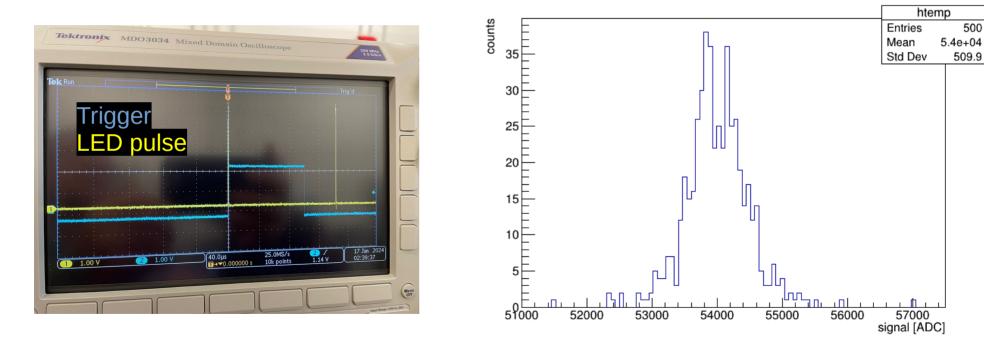
- ≻ Hypothesis: d_M is related to the (ADC) conversion time of the channel.
- Board config: 3 ADCs, 4 chips for each ADC, 14 channels for each chip.
- Conversion time for each channel ~ 7.2 us
- \succ Chip 8 channel 17 \rightarrow 1st chip of the 3rd ADC, 18th channel
 - > Measured $d_M \sim 120$ us
 - ≻ Computed (17*7.2) d_M ~ 120 us
- Chip 9 channel 18 \rightarrow 2nd chip of the 3rd ADC, 19th channel
 - > Measured $d_M \sim 320$ us
 - ≻ Computed ((18+24)*7.2) d_M ~ 300





Test with single trigger and LED pulse

- Even with a single trigger followed by a single LED pulse the signals are in the same region.
- Channel 18, chip 9, pulse width = 3 us.



All events have gain flag = 1!

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